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FDB031N08 N-Channel PowerTrench[®] MOSFET 75 V, 235 A, 3.1 m Ω

Features

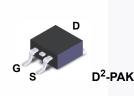
- $R_{DS(on)}$ = 2.4 m Ω (Typ.) @ V_{GS} = 10 V, I_D = 75 A
- · Fast Switching Speed
- Low Gate Charge
- High Performance Trench Technology for Extremely Low $R_{\text{DS}(\text{on})}$
- High Power and Current Handling Capability
- RoHS Compliant

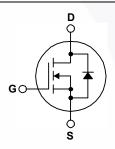
Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench[®] process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection Circuit
- Motor Drives and Uninterruptible Power Supplies





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		Parameter		FDB031N08	Unit
V _{DSS}	Drain to Source Voltage		75	V	
V _{GSS}	Gate to Source Voltage		±20	V	
ID	Drain Current - Continuous (T _C = 25 ^o C, Silicon Limited) - Continuous (T _C = 100 ^o C, Silicon Limited)			235	Α
				165	A
	-	Continuous (T _C = 25 ^o C, Pack	age Limited)	120	Α
I _{DM}	Drain Current	- Pulsed	(Note 1)	940	А
E _{AS}	Single Pulsed Avalanche Energy		(Note 2)	1995	mJ
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	5.5	V/ns
P _D	Dower Dissinction	(T _C = 25 ^o C)		375	W
	Power Dissipation	- Derate Above 25°C		2.5	W/ºC
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +175	°C
ΤL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 S		for 5 Seconds	300	°C

Thermal Characteristics

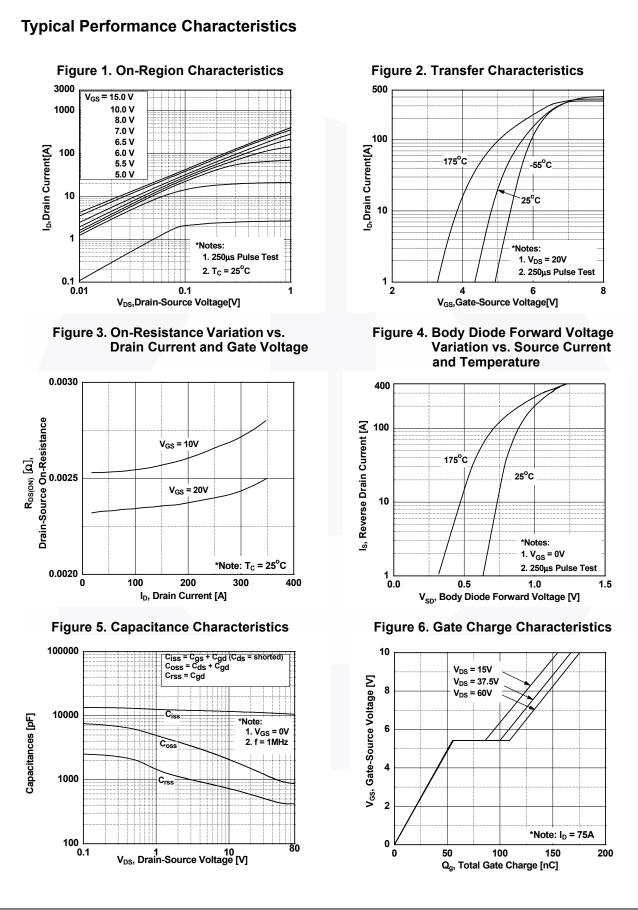
Symbol	Parameter	FDB031N08	Unit
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	0.4	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	°C/w

November 2013

FDB031N08 naracteristics T _C = 25 Parameter stics min to Source Breakdown Voltage akdown Voltage Temperature efficient	ge I _D	Tape and Reel herwise noted. Test Condition $_{0} = 250 \ \mu A, V_{GS} = 0 \ V$	I	Min.	24 mm	800 Max.	units Unit
Parameter stics in to Source Breakdown Voltag akdown Voltage Temperature	ge I _D	Test Condition	L	Min.	Тур.	Max.	Unit
Parameter stics in to Source Breakdown Voltag akdown Voltage Temperature	ge I _D	Test Condition	L	Min.	Тур.	Max.	Unit
in to Source Breakdown Voltage akdown Voltage Temperature		= 250 uA. V _{CS} = 0 V				1	
in to Source Breakdown Voltage akdown Voltage Temperature		= 250 µA. V _{CS} = 0 V					
akdown Voltage Temperature			$T_{\rm C} = 25^{\circ}{\rm C}$	75	-	-	V
			-		0.05		
	5	I_D = 250 µA, Referenced to 25°C		-	0.05	-	V/°C
Zero Gate Voltage Drain Current		_{DS} = 75 V, V _{GS} = 0 V		-	-	1 μ/	
		_{DS} = 75 V, T _C = 150°0		-	-	500	- po .
te to Body Leakage Current	V	$_{\rm GS}$ = ±20 V, V _{DS} = 0 \	/	-	-	±100	nA
stics							
	V	aa = Vaa Ia = 250 uu	Δ	2.5	3.5	45	V
			<u> </u>	-			mΩ
						-	S
					100		
acteristics							
ut Capacitance	V	$V_{DS} = 25 V, V_{GS} = 0 V,$ f = 1 MHz		-	11400	15160	pF
put Capacitance				-	1360	1810	pF
verse Transfer Capacitance	•	1 10112		-	595	800	pF
al Gate Charge at 10V	V	V _{DS} = 60 V, I _D = 75 A, V _{GS} = 10 V		-	169	220	nC
te to Source Gate Charge				-	60	-	nC
te to Drain "Miller" Charge			(Note 4)	-	47	-	nC
racteristics							
					230	470	ns
,	v	nn = 37 5 V In = 75 A	4				ns
							ns
,			(Note 4)				ns
			(1000 4)	-	121	202	113
	urce Diode F	orward Current			_	235	A
				-	-		A
				-	-		V
				-	53	-	ns
verse Recovery Charge				-		-	nC
	ward Transconductance acteristics ut Capacitance put Capacitance verse Transfer Capacitance al Gate Charge at 10V te to Source Gate Charge te to Drain "Miller" Charge racteristics n-On Delay Time n-Off Delay Time n-Off Fall Time Diode Characteristics timum Continuous Drain to Source in to Source Diode Forward Vo terse Recovery Time rerse Recovery Charge width limited by maximum junction tempe	te Threshold Voltage V, tic Drain to Source On Resistance V, ward Transconductance V acteristics ut Capacitance V put Capacitance V put Capacitance V rese Transfer Capacitance A al Gate Charge at 10V V te to Source Gate Charge V te to Drain "Miller" Charge V racteristics n-On Delay Time n-Off Delay Time n-Off Fall Time V Diode Characteristics timum Continuous Drain to Source Diode Forward in to Source Diode Forward Voltage V, rerse Recovery Time V, rerse Recovery Charge dl width limited by maximum junction temperature.	te Threshold Voltage $V_{GS} = V_{DS}$, $I_D = 250 \mu/$ tic Drain to Source On Resistance $V_{GS} = 10 V$, $I_D = 75 A$ ward Transconductance $V_{DS} = 10 V$, $I_D = 75 A$ acteristics ut Capacitance $V_{DS} = 25 V$, $V_{GS} = 0 V$, f = 1 MHz $V_{DS} = 25 V$, $V_{GS} = 0 V$, f = 1 MHz $V_{DS} = 60 V$, $I_D = 75 A$, verse Transfer Capacitance $V_{DS} = 60 V$, $I_D = 75 A$, ie to Source Gate Charge $V_{GS} = 10 V$ racteristics n-On Delay Time $V_{DD} = 37.5 V$, $I_D = 75 A$, h-Off Delay Time $V_{DD} = 37.5 V$, $I_D = 75 A$, h-Off Fall Time $V_{DD} = 37.5 V$, $I_D = 75 A$, conduction of the transment of the transm	te Threshold Voltage $V_{GS} = V_{DS}, I_D = 250 \mu\text{A}$ tic Drain to Source On Resistance $V_{GS} = 10 \text{V}, I_D = 75 \text{A}$ ward Transconductance $V_{DS} = 10 \text{V}, I_D = 75 \text{A}$ acteristics ut Capacitance $V_{DS} = 25 \text{V}, V_{GS} = 0 \text{V}, f = 1 \text{MHz}$ rese Transfer Capacitance al Gate Charge $V_{DS} = 60 \text{V}, I_D = 75 \text{A}, V_{GS} = 10 \text{V}$ te to Source Gate Charge $V_{GS} = 10 \text{V}$ (Note 4) racteristics n-On Rise Time $V_{DD} = 37.5 \text{V}, I_D = 75 \text{A}, R_G = 25 \Omega, V_{GS} = 10 \text{V}$ n-Off Delay Time $V_{DD} = 37.5 \text{V}, I_D = 75 \text{A}, R_G = 25 \Omega, V_{GS} = 10 \text{V}$ in the continuous Drain to Source Diode Forward Current (Note 4) Diode Characteristics simum Continuous Drain to Source Diode Forward Current in to Source Diode Forwar	te Threshold Voltage $V_{GS} = V_{DS}$, $I_D = 250 \ \mu A$ 2.5 tic Drain to Source On Resistance $V_{GS} = 10 \ V$, $I_D = 75 \ A$ - ward Transconductance $V_{DS} = 10 \ V$, $I_D = 75 \ A$ - acteristics ut Capacitance $V_{DS} = 25 \ V$, $V_{GS} = 0 \ V$, $\frac{1}{f = 1 \ MHz}$ - al Gate Charge at 10V $V_{DS} = 60 \ V$, $I_D = 75 \ A$, $\frac{1}{V_{CS} = 10 \ V}$ $\frac{1}{V_{CS} = 10 \ V}$ $\frac{1}{V_{CS} = 10 \ V}$ te to Source Gate Charge $V_{DS} = 60 \ V$, $I_D = 75 \ A$, $\frac{1}{V_{CS} = 10 \ V}$ $\frac{1}{V_{CS} =$	te Threshold Voltage $V_{GS} = V_{DS}$, $I_D = 250 \ \mu A$ 2.5 3.5 tic Drain to Source On Resistance $V_{GS} = 10 \ V$, $I_D = 75 \ A$ - 2.4 ward Transconductance $V_{DS} = 10 \ V$, $I_D = 75 \ A$ - 180 acteristics ut Capacitance $V_{DS} = 25 \ V$, $V_{GS} = 0 \ V$, f = 1 MHz - 1360 rerse Transfer Capacitance f = 1 MHz - 595 al Gate Charge at 10V $V_{DS} = 60 \ V$, $I_D = 75 \ A$, te to Source Gate Charge $V_{GS} = 10 \ V$ (Note 4) - 169 reacteristics n-On Delay Time $V_{DS} = 10 \ V$ (Note 4) - 47 racteristics n-On Delay Time $V_{DD} = 37.5 \ V$, $I_D = 75 \ A$, n-Off Fall Time $V_{CS} = 10 \ V$ (Note 4) - 121 Diode Characteristics timum Continuous Drain to Source Diode Forward Current - in to Source Diode Forward Current - 533 erse Recovery Time $V_{GS} = 0 \ V, I_S = 75 \ A, - 533$ erse Recovery Charge $V_{GS} = 0 \ V, I_S = 75 \ A, - 533$ width limited by maximum junction temperature.	te Threshold Voltage $V_{GS} = V_{DS}$, $I_D = 250 \ \mu A$ 2.5 3.5 4.5 tic Drain to Source On Resistance $V_{GS} = 10 \ V$, $I_D = 75 \ A$ - 2.4 3.1 ward Transconductance $V_{DS} = 10 \ V$, $I_D = 75 \ A$ - 180 - acteristics ut Capacitance $V_{DS} = 10 \ V$, $I_D = 75 \ A$ - 11400 15160 - 1360 1810 - 595 800 al Gate Charge at 10V $V_{DS} = 60 \ V$, $I_D = 75 \ A$, rest Transfer Capacitance $V_{GS} = 10 \ V$ (Note 4) - 169 220 - 60 - te to Drain "Miller" Charge $V_{GS} = 10 \ V$ (Note 4) - 47 - racteristics

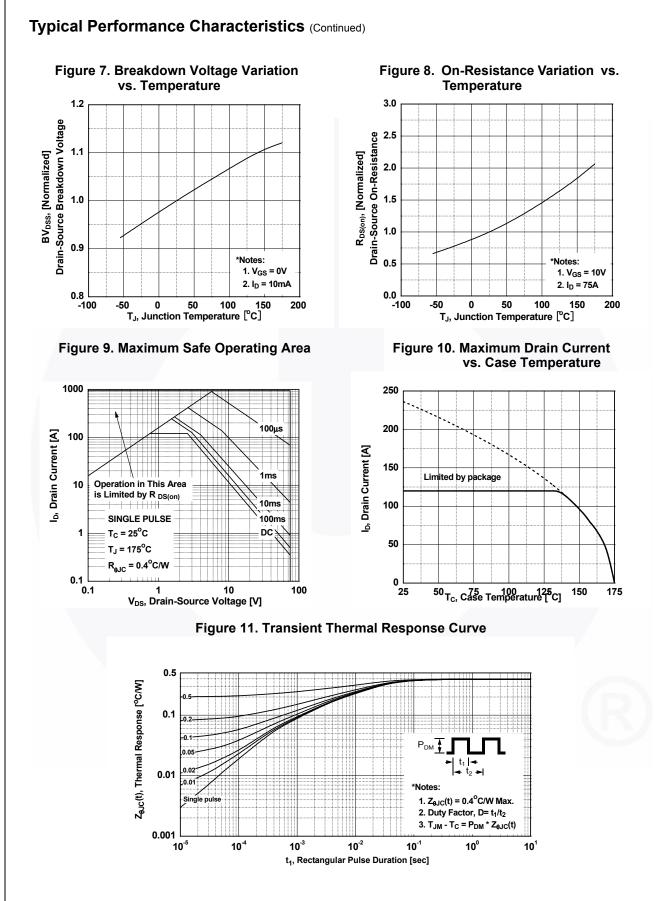
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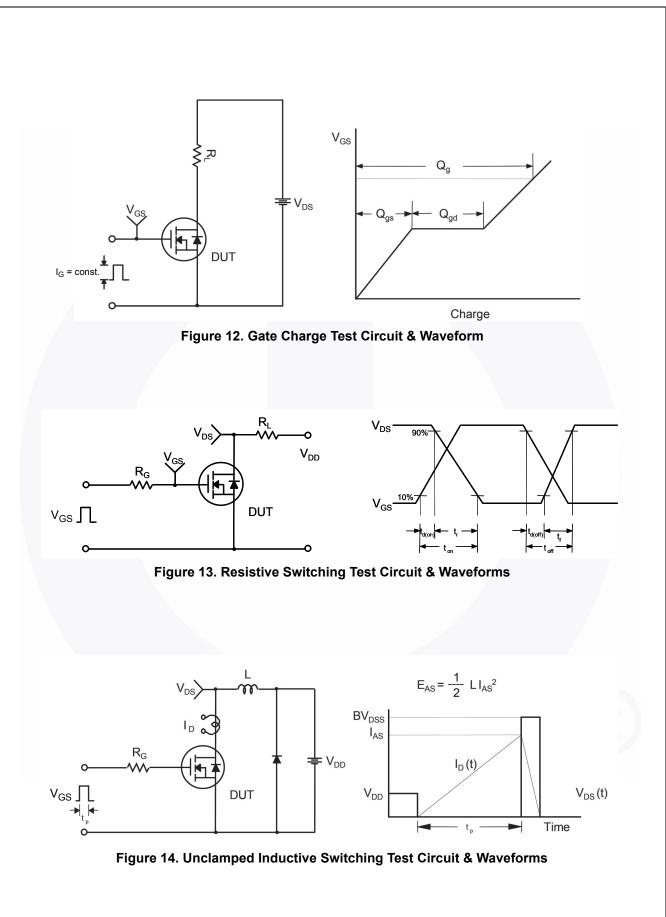
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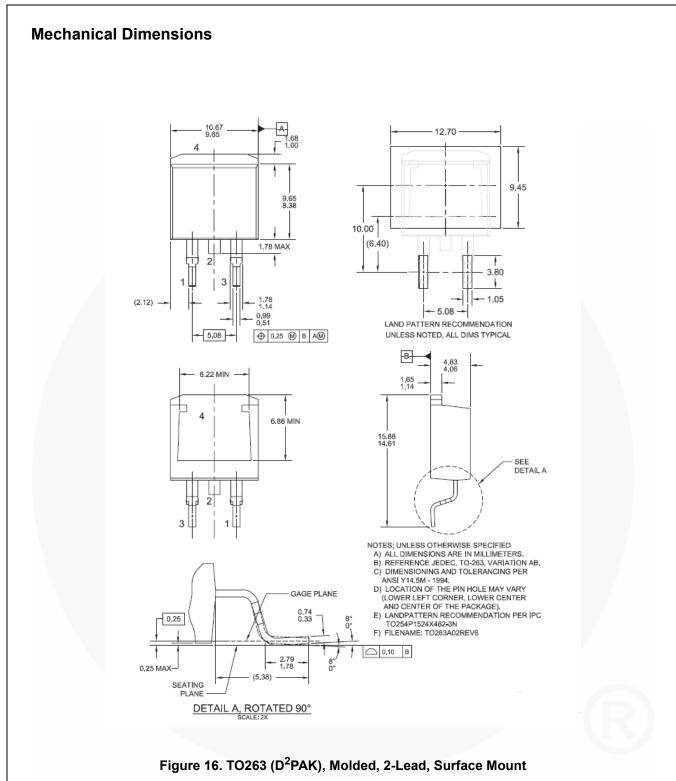




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DUT + V_{DS} a ۱_{SD} م L Driver R_G, Same Type as DUT L F ∨_{DD} $\prod V_{GS}$ • dv/dt controlled by R_{G} • I_{SD} controlled by pulse period Î Gate Pulse Width V_{GS} D = Gate Pulse Period 10V (Driver) I_{FM}, Body Diode Forward Current I _{SD} di/dt (DUT) I_{RM} Body Diode Reverse Current V_{DS} (DUT) Body Diode Recovery dv/dt V_{SD} V_{DD} Body Diode Forward Voltage Drop Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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